

Complementary MOSFET

ELM14604AA-N

■General Description

ELM14604AA-N uses advanced trench technology to provide excellent $R_{ds(on)}$ and low gate charge.

■Features

- | | |
|---------------------------------------|--|
| N-channel | P-channel |
| $V_{ds}=30V$ | $V_{ds}=-30V$ |
| $Id=6.9A(V_{gs}=10V)$ | $Id=-5A(V_{gs}=-10V)$ |
| $R_{ds(on)} < 28m\Omega(V_{gs}=10V)$ | $R_{ds(on)} < 52m\Omega(V_{gs}=-10V)$ |
| $R_{ds(on)} < 42m\Omega(V_{gs}=4.5V)$ | $R_{ds(on)} < 87m\Omega(V_{gs}=-4.5V)$ |

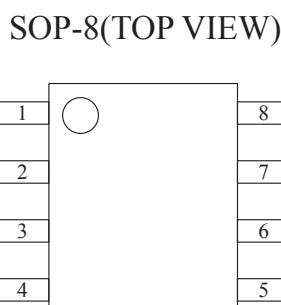
■Maximum Absolute Ratings

Parameter	Symbol	N-ch (Max.)	P-ch (Max.)	Unit	Note
Drain-source voltage	V_{ds}	30	-30	V	
Gate-source voltage	V_{gs}	± 20	± 20	V	
Continuous drain current	Id	6.9	-5.0	A	1
		5.8	-4.2		
Pulsed drain current	Idm	30	-20	A	2
Power dissipation	P_d	2.00	2.00	W	
		1.44	1.44		
Junction and storage temperature range	T_j, T_{stg}	-55 to 150	-55 to 150	°C	

■Thermal Characteristics

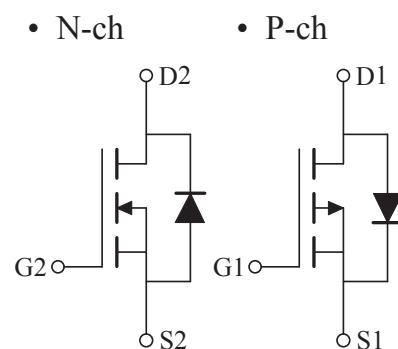
Parameter	Symbol	Device	Typ.	Max.	Unit	Note
Maximum junction-to-ambient	$R_{\theta ja}$	N-ch	48.0	62.5	°C/W	1
Maximum junction-to-ambient			74.0	110.0	°C/W	
Maximum junction-to-lead			35.0	40.0	°C/W	3
Maximum junction-to-ambient	$R_{\theta ja}$	P-ch	48.0	62.5	°C/W	1
Maximum junction-to-ambient			74.0	110.0	°C/W	
Maximum junction-to-lead			35.0	40.0	°C/W	3

■Pin configuration



Pin No.	Pin name
1	SOURCE2
2	GATE2
3	SOURCE1
4	GATE1
5	DRAIN1
6	DRAIN1
7	DRAIN2
8	DRAIN2

■Circuit



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■Electrical Characteristics (N-ch)

T_a=25°C

Parameter	Symbol	Conditions		Min.	Typ.	Max.	Unit	
STATIC PARAMETERS								
Drain-source breakdown voltage	BVdss	Id=250µA, Vgs=0V		30			V	
Zero gate voltage drain current	Idss	Vds=24V, Vgs=0V	Tj=55°C		0.004	1.000	µA	
						5.000		
Gate-body leakage current	Igss	Vds=0V, Vgs=±20V				100	nA	
Gate threshold voltage	Vgs(th)	Vds=Vgs, Id=250µA		1.0	1.9	3.0	V	
On state drain current	Id(on)	Vgs=4.5V, Vds=5V		20			A	
Static drain-source on-resistance	Rds(on)	Vgs=10V, Id=6.9A			22.5	28.0	mΩ	
		Tj=125°C			31.3	38.0		
		Vgs=4.5V, Id=5.0A			34.5	42.0		
Forward transconductance	Gfs	Vds=5V, Id=6.9A		10.0	15.4		S	
Diode forward voltage	Vsd	Is=1A			0.76	1.00	V	
Max.body-diode continuous current	Is					3	A	
DYNAMIC PARAMETERS								
Input capacitance	Ciss	Vgs=0V, Vds=15V, f=1MHz			680	820	pF	
Output capacitance	Coss				102		pF	
Reverse transfer capacitance	Crss				77		pF	
Gate resistance	Rg	Vgs=0V, Vds=0V, f=1MHz			3.0	3.6	Ω	
SWITCHING PARAMETERS								
Total gate charge (10V)	Qg	Vgs=10V, Vds=15V, Id=6.9A			13.84	17.00	nC	
Total gate charge (4.5V)	Qg				6.74	8.10	nC	
Gate-source charge	Qgs				1.82		nC	
Gate-drain charge	Qgd				3.20		nC	
Turn-on delay time	td(on)	Vgs=10V, Vds=15V RL=2.2Ω, Rgen=3Ω			4.6		ns	
Turn-on rise time	tr				4.1		ns	
Turn-off delay time	td(off)				20.6		ns	
Turn-off fall time	tf				5.2		ns	
Body-diode reverse recovery time	trr	If=6.9A, dl/dt=100A/µs			16.5	20.0	ns	
Body-diode reverse recovery charge	Qrr	If=6.9A, dl/dt=100A/µs			7.8		nC	

NOTE :

1. The value of R_{θja} is measured with the device mounted on 1in² FR-4 board of 2oz. Copper, in still air environment with T_a=25°C. The value in any given applications depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.
2. Repetitive rating, pulse width limited by junction temperature.
3. The R_{θja} is the sum of the thermal impedance from junction to lead R_{θjl} and lead to ambient.
4. The static characteristics in Figures 1 to 6 are obtained using 80µs pulses, duty cycle 0.5%max.
5. These tests are performed with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_a=25°C. The SOA curve provides a single pulse rating.



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■ Typical Electrical and Thermal Characteristics (N-ch)

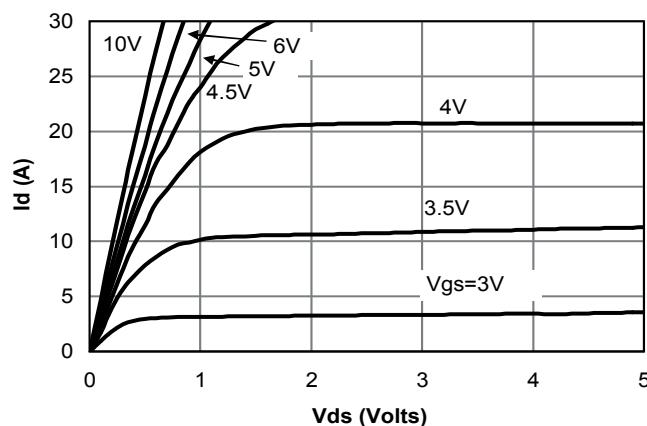


Fig 1: On-Region Characteristics

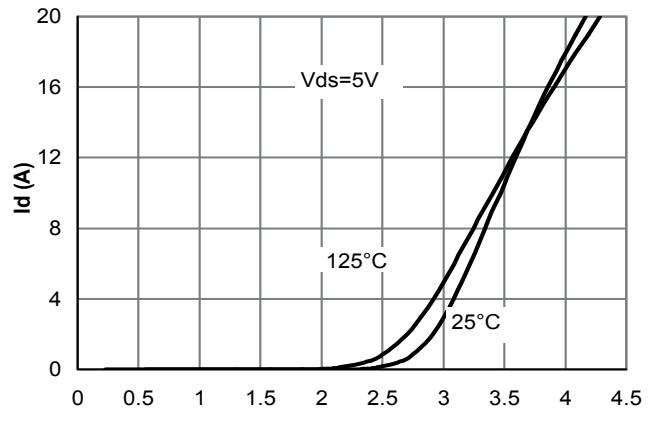


Figure 2: Transfer Characteristics

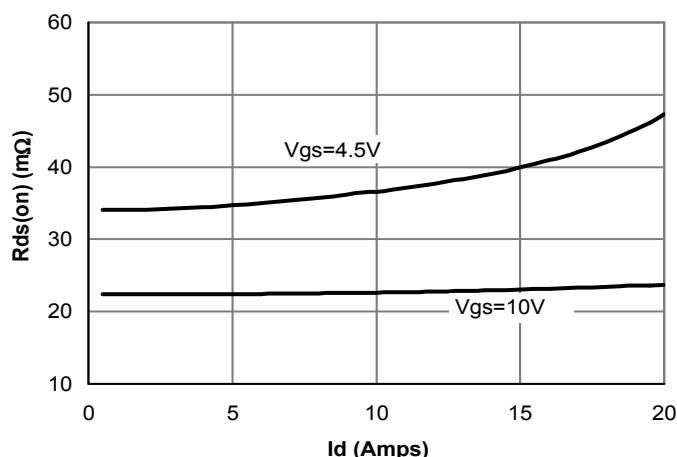


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

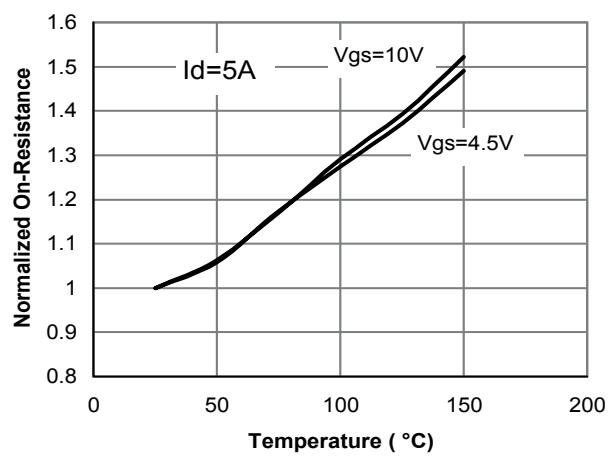


Figure 4: On-Resistance vs. Junction Temperature

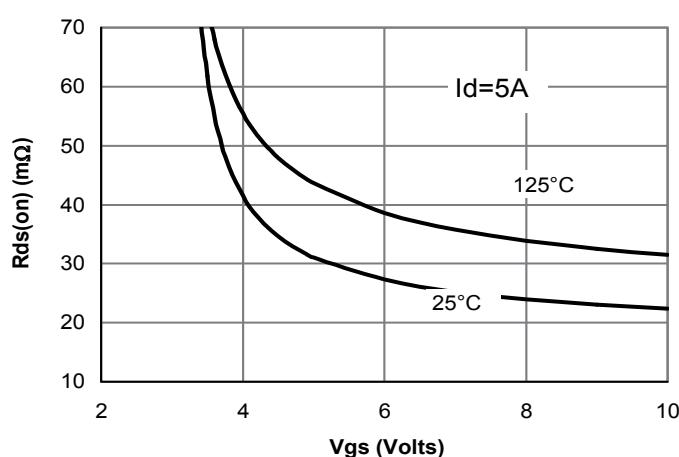


Figure 5: On-Resistance vs. Gate-Source Voltage

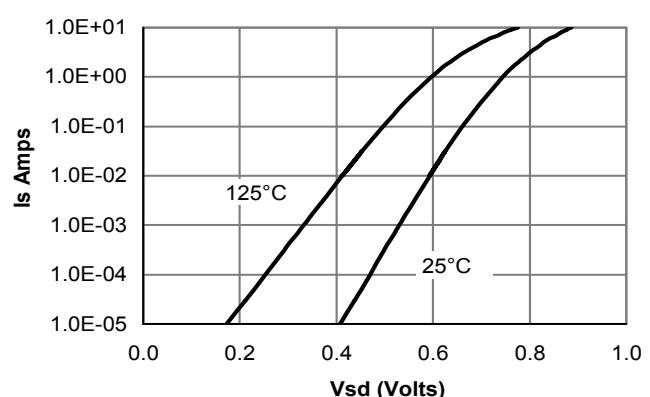
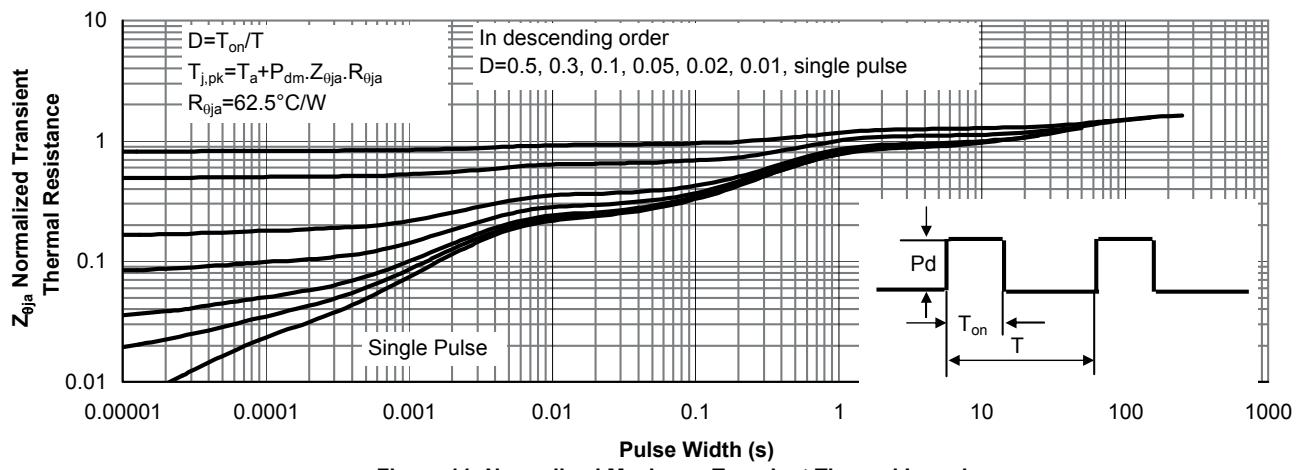
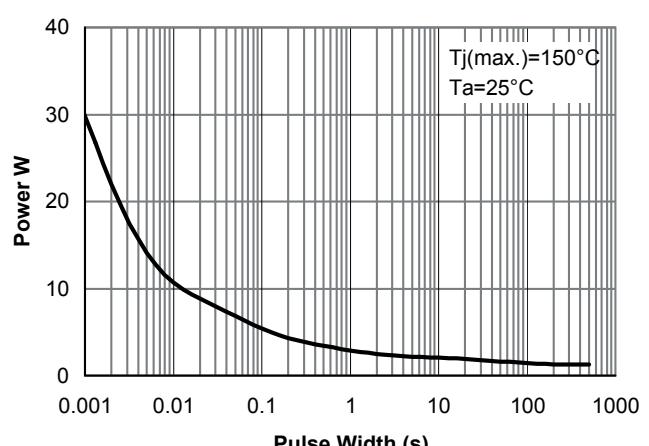
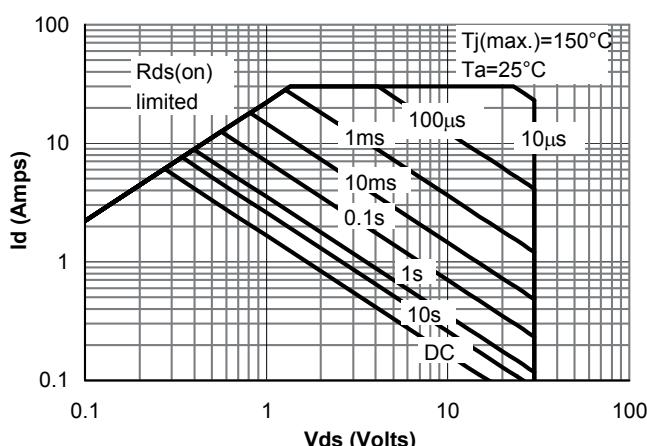
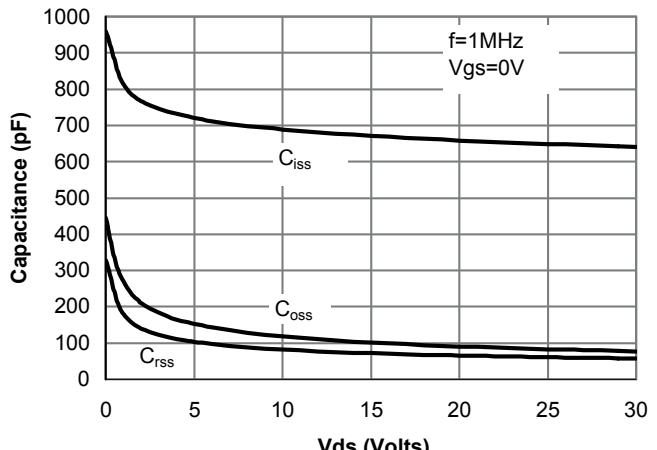
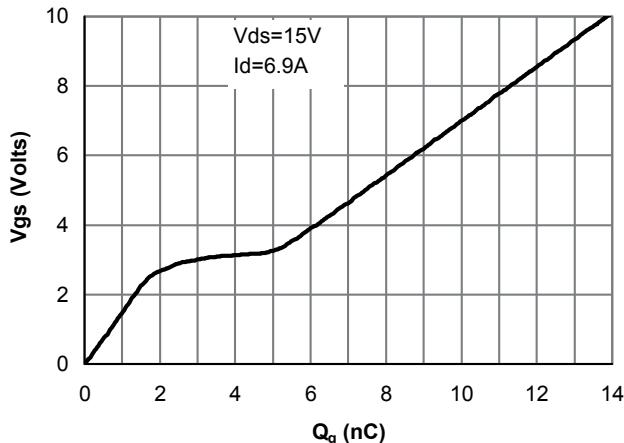


Figure 6: Body diode characteristics

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■Electrical Characteristics (P-ch)

T_a=25°C

Parameter	Symbol	Conditions		Min.	Typ.	Max.	Unit	
STATIC PARAMETERS								
Drain-source breakdown voltage	BVdss	Id=250µA, Vgs=0V		-30			V	
Zero gate voltage drain current	Idss	Vds=-24V, Vgs=0V	T _j =55°C			-1	µA	
						-5		
Gate-body leakage current	Igss	Vds=0V, Vgs=±20V				±100	nA	
Gate threshold voltage	Vgs(th)	Vds=Vgs, Id=250µA		-1.0	-1.8	-3.0	V	
On state drain current	Id(on)	Vgs=-4.5V, Vds=-5V		-20			A	
Static drain-source on-resistance	Rds(on)	Vgs=-10V, Id=-5A	T _j =125°C		39	52	mΩ	
					54	70		
		Vgs=-4.5V, Id=-4A			67	87	mΩ	
Forward transconductance	Gfs	Vds=-5V, Id=-5A		6.0	8.6		S	
Diode forward voltage	Vsd	Is=-1A, Vgs=0V			-0.77	-1.00	V	
Max. body-diode continuous current	Is					-2.8	A	
DYNAMIC PARAMETERS								
Input capacitance	Ciss	Vgs=0V, Vds=-15V, f=1MHz			700	900	pF	
Output capacitance	Coss				120		pF	
Reverse transfer capacitance	Crss				75		pF	
Gate resistance	Rg	Vgs=0V, Vds=0V, f=1MHz			10	15	Ω	
SWITCHING PARAMETERS								
Total gate charge (10V)	Qg	Vgs=-10V, Vds=-15V, Id=-5A			14.7	19.0	nC	
Total gate charge (4.5V)	Qg				7.6	10.0	nC	
Gate-source charge	Qgs				2.0		nC	
Gate-drain charge	Qgd				3.8		nC	
Turn-on delay time	td(on)	Vgs=-10V, Vds=-15V Rl=3Ω, Rgen=3Ω			8.3		ns	
Turn-on rise time	tr				5.0		ns	
Turn-off delay time	td(off)				29.0		ns	
Turn-off fall time	tf				14.0		ns	
Body diode reverse recovery time	trr	If=-5A, dl/dt=100A/µs			23.5	30.0	ns	
Body diode reverse recovery charge	Qrr	If=-5A, dl/dt=100A/µs			13.4		nC	

NOTE :

1. The value of R_{θja} is measured with the device mounted on 1in² FR-4 board of 2oz. Copper, in still air environment with T_a=25°C. The value in any given applications depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.
2. Repetitive rating, pulse width limited by junction temperature.
3. The R_{θja} is the sum of the thermal impedance from junction to lead R_{θjl} and lead to ambient.
4. The static characteristics in Figures 1 to 6 are obtained using 80µs pulses, duty cycle 0.5%max.
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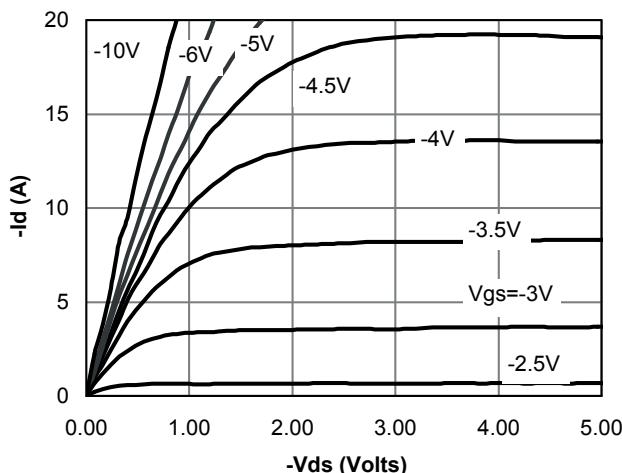


Figure 1: On-Region Characteristics

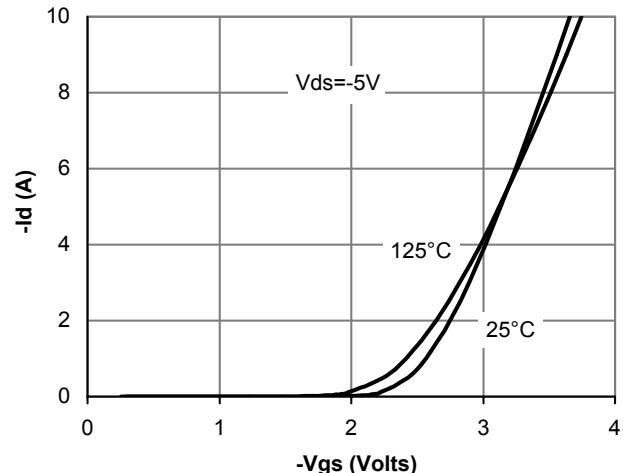


Figure 2: Transfer Characteristics

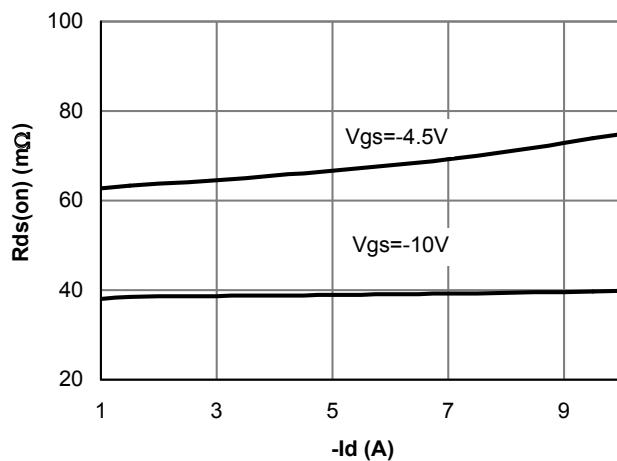


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

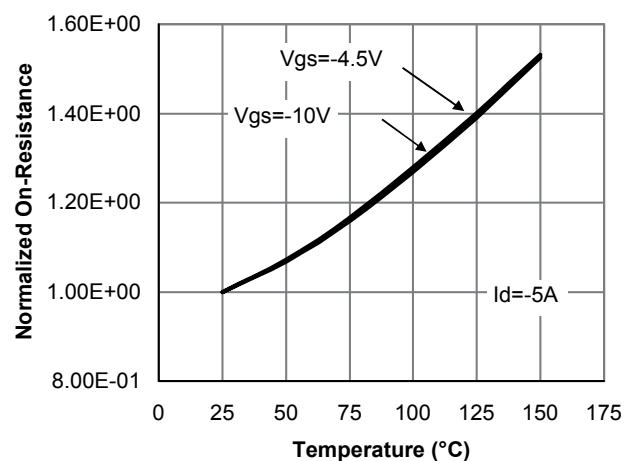


Figure 4: On-Resistance vs. Junction Temperature

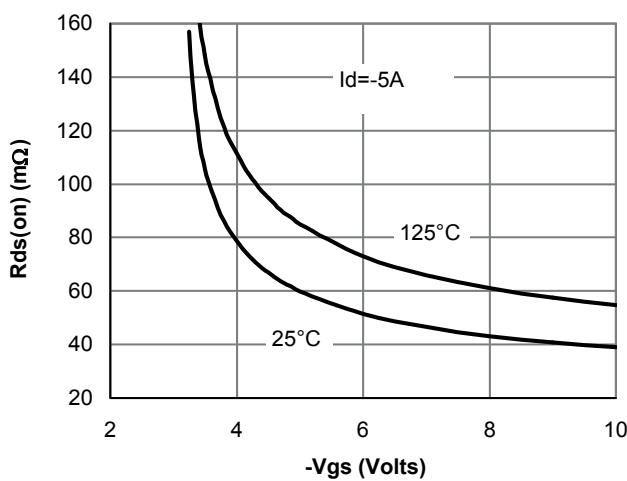


Figure 5: On-Resistance vs. Gate-Source Voltage

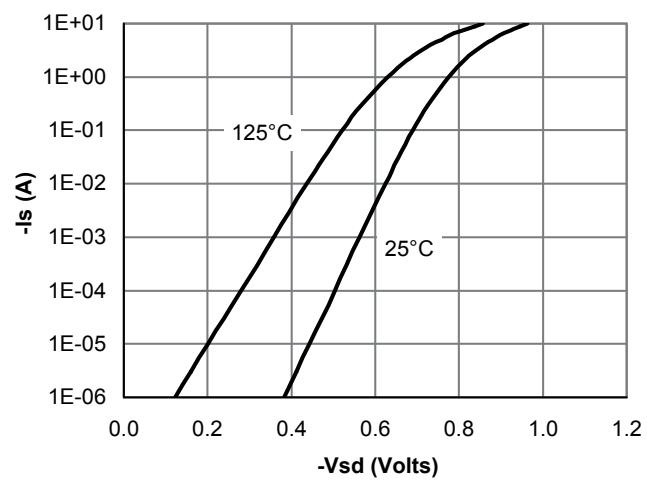


Figure 6: Body-Diode Characteristics

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